Applicant(s)/Patent Under Application/Control No. Reexamination 10/501,201 CHO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2821 **Tuyet Vo U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0097203 07-2002 Onozawa et al. 345/67 Α US-В US-С US-D Е US-F US-US-G US-Н USı US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х